Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/611,978	FUJIWARA ET AL.	
Examiner	Art Unit	
Tianiie Chen	2656	

SEARCHED					
Class	Subclass	Date	Examiner		
360	324.1				
	324.12				
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	322				
	324	11/14/2005	TJ		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Report	11/14/2005	TJ		